## The Metal Oxide Semiconductor Field Effect Transistor (MOSFET)

Just as with the BJT, a complete of a MOSFET is well outside the scope of this class. However, a basic understanding of what happens in a MOSFET and an example of a simple model are provided below. For more information, several excellent texts exist for beginners, including Fundamentals of Microelectronics by Razavi and The Art of Electronics by Horowitz and Hill.

The simplest symbol for a MOSFET, which stands for metal-oxide semiconductor field-effect transistor, is shown below.

(a) MOSFET symbol

(b) Voltages

The vast majority of commercial computer processors are built with MOSFETs. A MOSFET has three terminals: the gate $(G)$, the source (S), and the drain (D). Actually, it has a fourth terminal, namely its body (B), but we will ignore it for now because for many applications it is simply connected to the ground terminal. The circuit symbol for the MOSFET may look somewhat unusual, but it is actually a stylized depiction of the physical cross section of a real MOSFET. In a real MOSFET, the gate consists of a very thin layer (< 500 nm thick) of a conducting material adjacent to an even thinner layer (<100 nm) of insulator. The insulator in turn is placed directly on the surface of a relatively large slab of semiconductor material, usually referred to as "the chip" in everyday conversation (usually made of silicon 0.5 to 1.5 mm thick). The drain and the source sections are fabricated into this semiconductor chip on either side of the gate.

Note that because the gate $G$ is separated from the rest of the transistor by the thin insulating layer, no current can flow from $G$ to either $D$ or $S$.

Nonetheless, it turns out that the voltage difference between terminals $G$ and $S$ is key to the operation of the MOSFET. Using terminal $S$ as a reference above (right), we denote $V_{D S}$ and $V_{G S}$ as the voltages at terminals $D$ and G , respectively. We also denote the current that flows through the MOSFET from D to S as $\mathrm{I}_{\mathrm{DS}}$. This simplification is justified by the assumption that no current flows through the gate node to either the drain or source node. The operation of the MOSFET can be analyzed by placing it in the simple circuit shown below, in which $V_{D D}$ is a dc power supply voltage usually set at a level close to but not greater than, the maximum rated value of $V_{D S}$ for the specific MOSFET model under consideration.

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Figure 4-25: MOSFET (a) circuit, (b) characteristic curves, (c) equivalent circuit, and (d) associated characteristic lines.

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\begin{equation*}
I_{\mathrm{DS}}=g V_{\mathrm{GS}} \tag{4.64}
\end{equation*}
$$

The resistance $R_{D}$ is external to the MOSFET, and its role will be discussed later. The input voltage is synonymous with $V_{G S}$ and the output voltage is synonymous with VDS.

Since current cannot flow from $G$ to either $D$ or $S$, the only current that can flow through the MOSFET is IDS. The dependence of IDS on VGS and VDS is shown for a typical MOSFET in Fig. 4-25(b) in the form of characteristic curves displaying the response of IDS to VDS at specific values of VGS. We observe that if VDS is greater than a certain saturation threshold value VSAT, the curves assume approximately constant levels, and that these levels are approximately proportional to VGS. These observations allow us to characterize the MOSFET in terms of the simple, equivalent circuit model shown in Fig. 4-25(c), which consists of a single dependent current source given by IDS = gVGS, (4.64) where $g$ is a MOSFET gain constant. The characteristic curves associated with this model, which is valid only if VDS exceeds VSAT, are shown in Fig. 4-25(d).

In real MOSFETs, the relationship between IDS and VGS at saturation is not strictly linear. How linear the relationship is depends (in part) on the size of the transistor. Modern sub-micron transistors used in digital processors exhibit a linear relationship between IDS and VGS at saturation, whereas larger MOSFETs used for power switching may behave nonlinearly. For our purposes, the simplification denoted by Eq. (4.64) will suffice.
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